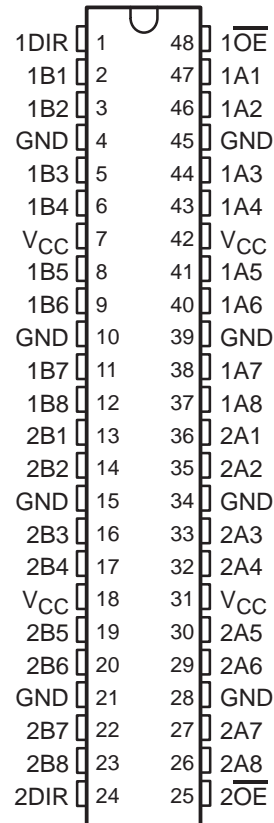


# SN54ABT16245, SN74ABT16245 16-BIT BUS TRANSCEIVERS WITH 3-STATE OUTPUTS

SCBS084B – D3712, JANUARY 1991 – REVISED DECEMBER 1992

- Members of the Texas Instruments *Widebus*™ Family
- State-of-the-Art *EPIC-II B*™ BiCMOS Design Significantly Reduces Power Dissipation
- Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17
- Typical  $V_{OLP}$  (Output Ground Bounce) < 1 V at  $V_{CC} = 5$  V,  $T_A = 25^\circ\text{C}$
- Distributed  $V_{CC}$  and GND Pin Configuration Minimizes High-Speed Switching Noise
- Flow-Through Architecture Optimizes PCB Layout
- High-Drive Outputs (–32-mA  $I_{OH}$ , 64-mA  $I_{OL}$ )
- Packaged in Plastic 300-mil Shrink Small-Outline and Thin Shrink Small-Outline Packages and 380-mil Fine-Pitch Ceramic Flat Packages Using 25-mil Center-to-Center Spacings

SN54ABT16245 . . . WD PACKAGE  
SN74ABT16245 . . . DGG OR DL PACKAGE  
(TOP VIEW)



## description

The 'ABT16245 is a 16-bit (dual-octal) noninverting 3-state transceiver designed for synchronous two-way communication between data buses. The control function implementation minimizes external timing requirements.

This device can be used as two 8-bit transceivers or one 16-bit transceiver. It allows data transmission from the A bus to the B bus or from the B bus to the A bus depending upon the logic level at the direction-control (DIR) input. The output-enable ( $\overline{OE}$ ) input can be used to disable the device so that the buses are effectively isolated.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN74ABT16245 is available in TI's shrink small-outline package (DL), which provides twice the I/O pin count and functionality of standard small-outline packages in the same printed-circuit-board area.

The SN54ABT16245 is characterized for operation over the full military temperature range of  $-55^\circ\text{C}$  to  $125^\circ\text{C}$ . The SN74ABT16245 is characterized for operation from  $-40^\circ\text{C}$  to  $85^\circ\text{C}$ .

FUNCTION TABLE  
(each 8-bit section)

INPUTS		OPERATION
$\overline{OE}$	DIR	
L	L	B data to A bus
L	H	A data to B bus
H	X	Isolation

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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

 **TEXAS  
INSTRUMENTS**

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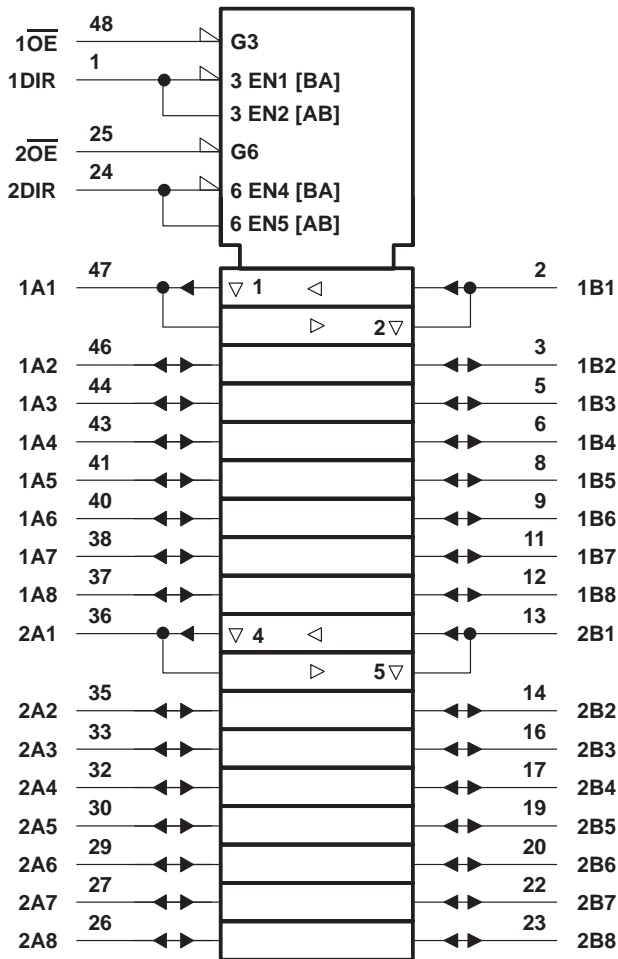
# SN54ABT16245, SN74ABT16245

## 16-BIT BUS TRANSCEIVERS

### WITH 3-STATE OUTPUTS

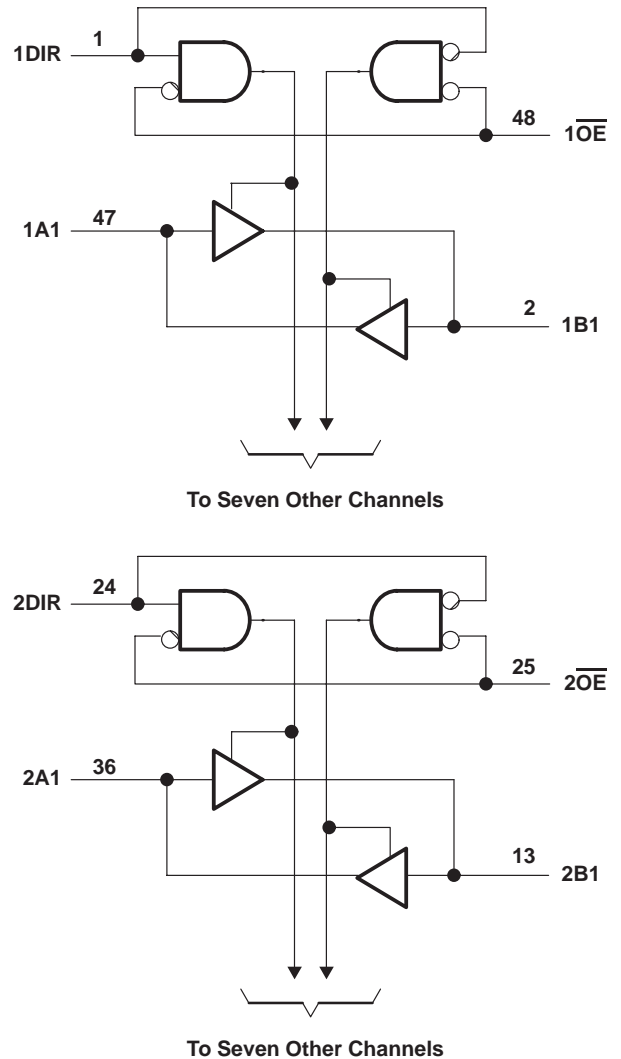
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#### logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

#### logic diagram (positive logic)



#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, $V_{CC}$ .....	-0.5 V to 7 V
Input voltage range, $V_I$ (except I/O ports) (see Note 1) .....	-0.5 V to 7 V
Voltage range applied to any output in the high state or power-off state, $V_O$ .....	-0.5 V to 5.5 V
Current into any output in the low state, $I_{O1}$ : SN54ABT16245 .....	96 mA
SN74ABT16245 .....	128 mA
Input clamp current, $I_{IK}$ ( $V_I < 0$ ) .....	-18 mA
Output clamp current, $I_{OK}$ ( $V_O < 0$ ) .....	-50 mA
Maximum power dissipation at $T_A = 55^\circ\text{C}$ (in still air): DGG package .....	0.8 W
DL package .....	0.85 W
Storage temperature range .....	-65°C to 150°C

‡ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

# SN54ABT16245, SN74ABT16245 16-BIT BUS TRANSCEIVERS WITH 3-STATE OUTPUTS

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## recommended operating conditions (see Note 2)

		SN54ABT16245		SN74ABT16245		UNIT
		MIN	MAX	MIN	MAX	
$V_{CC}$	Supply voltage	4.5	5.5	4.5	5.5	V
$V_{IH}$	High-level input voltage	2		2		V
$V_{IL}$	Low-level input voltage		0.8		0.8	V
$V_I$	Input voltage	0	$V_{CC}$	0	$V_{CC}$	V
$I_{OH}$	High-level output current		-24		-32	mA
$I_{OL}$	Low-level output current		48		64	mA
$\Delta t/\Delta v$	Input transition rise or fall rate	Outputs enabled		10	10	ns/V
$T_A$	Operating free-air temperature	-55	125	-40	85	°C

NOTE 2: Unused or floating pins (input or I/O) must be held high or low.

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	$T_A = 25^\circ\text{C}$			SN54ABT16245		SN74ABT16245		UNIT
		MIN	TYP†	MAX	MIN	MAX	MIN	MAX	
$V_{IK}$	$V_{CC} = 4.5\text{ V}$ , $I_I = -18\text{ mA}$			-1.2	-1.2		-1.2	V	
$V_{OH}$	$V_{CC} = 4.5\text{ V}$ , $I_{OH} = -3\text{ mA}$	2.5			2.5		2.5	V	
	$V_{CC} = 5\text{ V}$ , $I_{OH} = -3\text{ mA}$	3			3		3		
	$V_{CC} = 4.5\text{ V}$ , $I_{OH} = -24\text{ mA}$	2			2				
	$V_{CC} = 4.5\text{ V}$ , $I_{OH} = -32\text{ mA}$	2‡					2		
$V_{OL}$	$V_{CC} = 4.5\text{ V}$ , $I_{OL} = 48\text{ mA}$			0.55	0.55			V	
	$V_{CC} = 4.5\text{ V}$ , $I_{OL} = 64\text{ mA}$			0.55‡			0.55		
$I_I$	$V_{CC} = 5.5\text{ V}$ , $V_I = V_{CC}$ or GND	Control inputs		$\pm 1$	$\pm 1$		$\pm 1$	$\mu\text{A}$	
		A or B ports		$\pm 100$	$\pm 100$		$\pm 100$		
$I_{OZH}^{\S}$	$V_{CC} = 5.5\text{ V}$ , $V_O = 2.7\text{ V}$			10¶	10		10¶	$\mu\text{A}$	
$I_{OZL}^{\S}$	$V_{CC} = 5.5\text{ V}$ , $V_O = 0.5\text{ V}$			-10¶	-10		-10¶	$\mu\text{A}$	
$I_{off}$	$V_{CC} = 0$ , $V_I$ or $V_O \leq 4.5\text{ V}$			$\pm 100$			$\pm 100$	$\mu\text{A}$	
$I_{CEX}$	$V_{CC} = 5.5\text{ V}$ , $V_O = 5.5\text{ V}$	Outputs high		50	50		50	$\mu\text{A}$	
$I_O^{\#}$	$V_{CC} = 5.5\text{ V}$ , $V_O = 2.5\text{ V}$		-50	-100	-180	-50	-180	mA	
$I_{CC}$	$V_{CC} = 5.5\text{ V}$ , $I_O = 0$ , $V_I = V_{CC}$ or GND	A or B ports	Outputs high		2	2	2	mA	
			Outputs low		32	32	32		
			Outputs disabled		2	2	2		
$\Delta I_{CC}^{  }$	$V_{CC} = 5.5\text{ V}$ , One input at 3.4 V, Other inputs at $V_{CC}$ or GND	Data inputs	Outputs enabled		1	1.5	1	mA	
			Outputs disabled		0.05	1	0.05		
		Control inputs		1.5	1.5	1.5			
$C_i$	$V_I = 2.5\text{ V}$ or $0.5\text{ V}$	Control inputs		3				pF	
$C_{io}$	$V_O = 2.5\text{ V}$ or $0.5\text{ V}$	A or B ports		8.5				pF	

† All typical values are at  $V_{CC} = 5\text{ V}$ .

‡ On products compliant to MIL-STD-883, Class B, this parameter does not apply.

§ The parameters  $I_{OZH}$  and  $I_{OZL}$  include the input leakage current.

¶ This data sheet limit may vary among suppliers.

# Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

|| This is the increase in supply current for each input that is at the specified TTL voltage level rather than  $V_{CC}$  or GND.



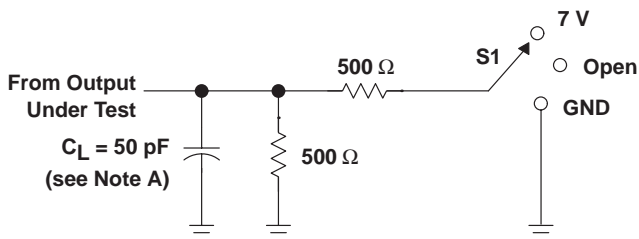
**SN54ABT16245, SN74ABT16245**  
**16-BIT BUS TRANSCEIVERS**  
**WITH 3-STATE OUTPUTS**

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switching characteristics over recommended ranges of supply voltage and operating free-air temperature,  $C_L = 50$  pF (unless otherwise noted) (see Figure 1)

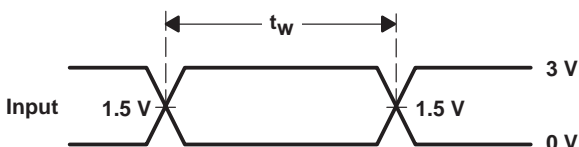
PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC} = 5$ V, $T_A = 25^\circ$ C			SN54ABT16245		SN74ABT16245		UNIT
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
$t_{PLH}$	A or B	B or A	1	2.2	3.4	0.5	4	1	3.9	ns
$t_{PHL}$			1	2.1	3.8	0.5	4.6	1	4.5	
$t_{PZH}$	OE	B or A	1	3.1	4.4	0.8	5.5	1	5.4	ns
$t_{PZL}$			1	3	6.1	0.9	7.3	1	7.2	
$t_{PHZ}$	OE	B or A	1.3	3.5	4.7	1.3	6.3	1.3	5.5	ns
$t_{PLZ}$			1.4	3.2	4.7	1.4	5.3	1.4	5.2	

PARAMETER MEASUREMENT INFORMATION

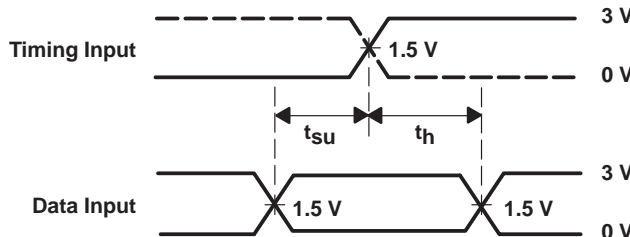


LOAD CIRCUIT FOR OUTPUTS

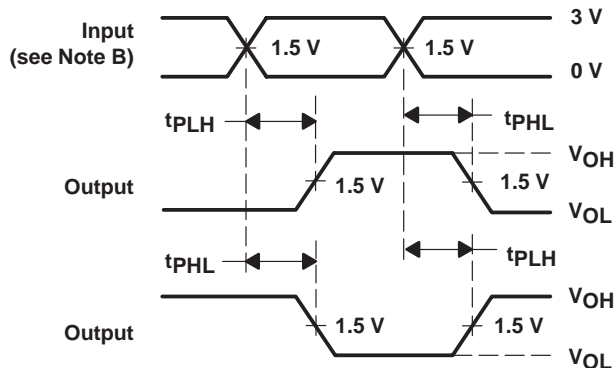
TEST	S1
$t_{PLH}/t_{PHL}$	Open
$t_{PLZ}/t_{PZL}$	7 V
$t_{PHZ}/t_{PZH}$	Open



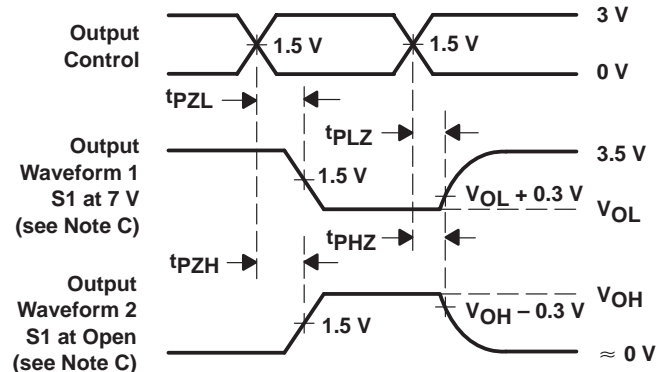
VOLTAGE WAVEFORMS  
PULSE DURATION



VOLTAGE WAVEFORMS  
SETUP AND HOLD TIMES



VOLTAGE WAVEFORMS  
PROPAGATION DELAY TIMES  
INVERTING AND NONINVERTING OUTPUTS



VOLTAGE WAVEFORMS  
ENABLE AND DISABLE TIMES  
LOW- AND HIGH-LEVEL ENABLING

- NOTES: A.  $C_L$  includes probe and jig capacitance.  
 B. All input pulses are supplied by generators having the following characteristics:  $PRR \leq 10$  MHz,  $Z_O = 50 \Omega$ ,  $t_r \leq 2.5$  ns,  $t_f \leq 2.5$  ns.  
 C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.  
 D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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